

## Notice of References Cited

Application/Control No.

Applicant(s)/Patent Under Reexamination BAE, SEUNG-HWAN

Examiner

Tim Bonura

Applicant(s)/Patent Under Reexamination BAE, SEUNG-HWAN

Art Unit
2114

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	М	US-			

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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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